



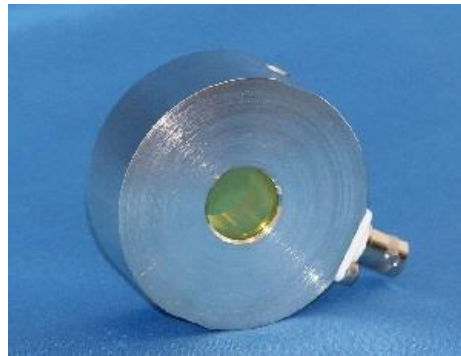
## Press Release

Star Tech Instruments is pleased to announce our newest NIST traceable, power probe, designed for X-ray and extreme UV measurements from 5-200 nm.

The XUV-18 probe has a highly sensitive, high damage threshold sensor, with vacuum compatibility to  $10^{-7}$  Torr. It features a wide range of input apertures, wavelengths, and measurements.

An Optional 4-decade, low noise, trans-impedance amplifier is available

Please contact us to discuss your application.



**Star Tech Instruments**  
**PO Box 1822**  
**New Fairfield, CT 06812**

[info@startechinstruments.com](mailto:info@startechinstruments.com)

203-312-0767



**Star Tech Instruments**

US Manufacturers of UV Laser Instrumentation since 1989